

## 74VHC4316

### Quad Analog Switch with Level Translator

#### General Description

These devices are digitally controlled analog switches implemented in advanced silicon-gate CMOS technology. These switches have low "on" resistance and low "off" leakages. They are bidirectional switches, thus any analog input may be used as an output and vice-versa. Three supply pins are provided on the 4316 to implement a level translator which enables this circuit to operate with 0V–6V logic levels and up to ±6V analog switch levels. The 4316 also has a common enable input in addition to each switch's control which when HIGH will disable all switches to their off state. All analog inputs and outputs and digital

inputs are protected from electrostatic damage by diodes to V<sub>CC</sub> and ground.

#### Features

- Typical switch enable time: 20 ns
- Wide analog input voltage range: ±6V
- Low "on" resistance: 50 typ. (V<sub>CC</sub>–V<sub>EE</sub> = 4.5V)  
30 typ. (V<sub>CC</sub>–V<sub>EE</sub> = 9V)
- Low quiescent current: 80 µA maximum (74VHC)
- Matched switch characteristics
- Individual switch controls plus a common enable
- Pin functional compatible with 74HC4316

#### Ordering Code:

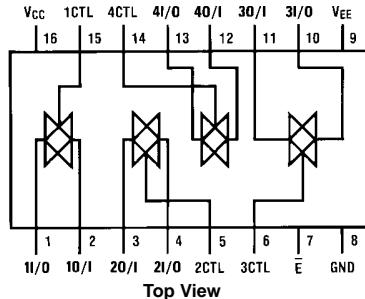
Order Number	Package Number	Package Description
74VHC4316M	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74VHC4316WM	M16B	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74VHC4316MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74VHC4316N	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Surface mount packages are also available on Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

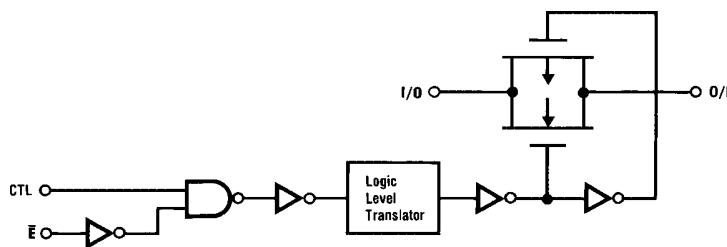
#### Truth Table

Inputs		Switch
$\bar{E}$	CTL	I/O–O/I
H	X	"OFF"
L	L	"OFF"
L	H	"ON"

#### Connection Diagram



#### Logic Diagram



Absolute Maximum Ratings <sup>(Note 1)</sup>			Recommended Operating Conditions					
(Note 2)								
Supply Voltage ( $V_{CC}$ )		-0.5 to +7.5V			Min	Max		
Supply Voltage ( $V_{EE}$ )		+0.5 to -7.5V	Supply Voltage ( $V_{CC}$ )	2	6	V		
DC Control Input Voltage ( $V_{IN}$ )		-1.5 to $V_{CC}+1.5V$	Supply Voltage ( $V_{EE}$ )	0	-6	V		
DC Switch I/O Voltage ( $V_{IO}$ )	$V_{EE}-0.5$ to $V_{CC}+0.5V$		DC Input or Output Voltage	0	$V_{CC}$	V		
Clamp Diode Current ( $I_{IK}, I_{OK}$ )		$\pm 20$ mA	( $V_{IN}, V_{OUT}$ )					
DC Output Current, per pin ( $I_{OUT}$ )		$\pm 25$ mA	Operating Temperature Range ( $T_A$ )	-40	+85	°C		
DC $V_{CC}$ or GND Current, per pin ( $I_{CC}$ )		$\pm 50$ mA	Input Rise or Fall Times					
Storage Temperature Range ( $T_{STG}$ )		-65°C to +150°C	( $t_r, t_f$ )	$V_{CC} = 2.0V$	1000	ns		
Power Dissipation ( $P_D$ ) (Note 3)		600 mW		$V_{CC} = 4.5V$	500	ns		
S.O. Package only		500 mW		$V_{CC} = 6.0V$	400	ns		
Lead Temperature ( $T_L$ )				$V_{CC} = 12.0V$	250	ns		
(Soldering 10 seconds)		260°C	<b>Note 1:</b> Absolute Maximum Ratings are those values beyond which damage to the device may occur.					
			<b>Note 2:</b> Unless otherwise specified all voltages are referenced to ground.					
			<b>Note 3:</b> Power Dissipation temperature derating — plastic "N" package: -12 mW/°C from 65°C to 85°C.					
DC Electrical Characteristics (Note 4)								
Symbol	Parameter	Conditions	$V_{EE}$	$V_{CC}$	$T_A = 25^\circ C$	$T_A = -40^\circ C \text{ to } +85^\circ C$	Units	
					Typ	Guaranteed Limits		
$V_{IH}$	Minimum HIGH Level Input Voltage			2.0V 4.5V 6.0V	1.5 3.15 4.2	1.5 3.15 4.2	V	
$V_{IL}$	Maximum LOW Level Input Voltage			2.0V 4.5V 6.0V	0.5 1.35 1.8	0.5 1.35 1.8	V	
$R_{ON}$	Minimum "ON" Resistance (Note 5)	$V_{CTL} = V_{IH}$ , $I_S = 2.0$ mA $V_{IS} = V_{CC}$ to $V_{EE}$ (Figure 1)	GND -4.5V -6.0V	4.5V 6.0V	100 40 30	170 85 70	200 105 85	$\Omega$
		$V_{CTL} = V_{IH}$ , $I_S = 2.0$ mA $V_{IS} = V_{CC}$ or $V_{EE}$ (Figure 1)	GND -4.5V -6.0V	2.0V 4.5V 6.0V	100 40 50 20	180 80 60 40	215 100 75 60	
$R_{ON}$	Maximum "ON" Resistance Matching	$V_{CTL} = V_{IH}$ $V_{IS} = V_{CC}$ to $V_{EE}$	GND -4.5V -6.0V	4.5V 6.0V	10 5 5	15 10 10	20 15 15	$\Omega$
$I_{IN}$	Maximum Control Input Current	$V_{IN} = V_{CC}$ or GND	GND	6.0V		$\pm 0.1$	$\pm 1.0$	$\mu A$
$I_{IZ}$	Maximum Switch "OFF" Leakage Current	$V_{OS} = V_{CC}$ or $V_{EE}$ $V_{IS} = V_{EE}$ or $V_{CC}$ $V_{CTL} = V_{IL}$ (Figure 2)	GND -6.0V	6.0V 6.0V		$\pm 30$ $\pm 50$	$\pm 300$ $\pm 500$	nA
$I_{IZ}$	Maximum Switch "ON" Leakage Current	$V_{IS} = V_{CC}$ to $V_{EE}$ $V_{CTL} = V_{IH}$ $V_{OS} = \text{OPEN}$ (Figure 3)	GND -6.0V	6.0V 6.0V		$\pm 20$ $\pm 30$	$\pm 75$ $\pm 150$	nA
$I_{CC}$	Maximum Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND $I_{OUT} = 0$ $\mu A$	GND -6.0V	6.0V 6.0V		1.0 4.0	10 40	$\mu A$
<b>Note 4:</b> For a power supply of 5V $\pm 10\%$ the worst case on resistances ( $R_{ON}$ ) occurs for VHC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case $V_{IH}$ and $V_{IL}$ occur at $V_{CC} = 5.5V$ and 4.5V respectively. (The $V_{IH}$ value at 5.5V is 3.85V.) The worst case leakage current occurs for CMOS at the higher voltage and so the 5.5V values should be used.								
<b>Note 5:</b> At supply voltages ( $V_{CC}$ – $V_{EE}$ ) approaching 2V the analog switch on resistance becomes extremely non-linear. Therefore it is recommended that these devices be used to transmit digital only when using these supply voltages.								

### AC Electrical Characteristics

$V_{CC} = 2.0V - 6.0V$ ,  $V_{EE} = 0V - 6V$ ,  $C_L = 50 \text{ pF}$  unless otherwise specified

Symbol	Parameter	Conditions	$V_{EE}$	$V_{CC}$	$T_A=+25^\circ\text{C}$		Guaranteed Limits	Units
					Typ			
$t_{PHL}, t_{PLH}$	Maximum Propagation Delay Switch In to Out		GND	3.3V	15	30	37	ns
			GND	4.5V	5	10	13	
			-4.5V	4.5V	4	8	12	
			-6.0V	6.0V	3	7	11	
$t_{PZL}, t_{PZH}$	Maximum Switch Turn "ON" Delay (Control)	$R_L = 1 \text{ k}\Omega$	GND	3.3V	25	97	120	ns
			GND	4.5V	20	35	43	
			-4.5V	4.5V	15	32	39	
			-6.0V	6.0V	14	30	37	
$t_{PHZ}, t_{PLZ}$	Maximum Switch Turn "OFF" Delay (Control)	$R_L = 1 \text{ k}\Omega$	GND	3.3V	35	145	180	ns
			GND	4.5V	25	50	63	
			-4.5V	4.5V	20	44	55	
			-6.0V	6.0V	20	44	55	
$t_{PZL}, t_{PZH}$	Maximum Switch Turn "ON" Delay (Enable)		GND	3.3V	27	120	150	ns
			GND	4.5V	20	41	52	
			-4.5V	4.5V	19	38	48	
			-6.0V	6.0V	18	36	45	
$t_{PLZ}, t_{PHZ}$	Maximum Switch Turn "OFF" Delay (Enable)		GND	3.3V	42	155	190	ns
			GND	4.5V	28	53	67	
			-4.5V	4.5V	23	47	59	
			-6.0V	6.0V	21	47	59	
	Minimum Frequency Response (Figure 7) $20 \log(V_{OS}/V_{IS}) = -3 \text{ dB}$	$R_L = 600\Omega, V_{IS} = 2V_{PP}$ at $(V_{CC}-V_{EE}/2)$ (Note 6)(Note 7)	0V -4.5V	4.5 4.5V	40 100			MHz
	Control to Switch Feedthrough Noise (Figure 8)	$R_L = 600\Omega, f = 1 \text{ MHz}$ $C_L = 50 \text{ pF}$ (Note 7)(Note 8)	0V -4.5V	4.5V 4.5V	100 250			mV
	Crosstalk Between any Two Switches (Figure 9)	$R_L = 600\Omega, f = 1 \text{ MHz}$	0V -4.5V	4.5V 4.5V	-52 -50			dB
	Switch OFF Signal Feedthrough Isolation (Figure 10)	$R_L = 600\Omega, f = 1 \text{ MHz}$ $V_{CTL} = V_{IL}$ (Note 7)(Note 8)	0V -4.5V	4.5V 4.5V	-42 -44			dB
THD	Sinewave Harmonic Distortion (Figure 11)	$R_L = 10 \text{ K}\Omega, C_L = 50 \text{ pF}, f = 1 \text{ kHz}$ $V_{IS} = 4 V_{PP}$ $V_{IS} = 8 V_{PP}$	0V -4.5V	4.5V 4.5V	0.013 0.008			%
$C_{IN}$	Maximum Control Input Capacitance				5			pF
$C_{IN}$	Maximum Switch Input Capacitance				35			pF
$C_{IN}$	Maximum Feedthrough Capacitance	$V_{CTL} = \text{GND}$			0.5			pF
$C_{PD}$	Power Dissipation Capacitance				15			pF

Note 6: Adjust 0 dBm for  $f = 1 \text{ kHz}$  (Null  $R_L/\text{Ron}$  Attenuation).

Note 7:  $V_{IS}$  is centered at  $V_{CC}-V_{EE}/2$ .

Note 8: Adjust for 0 dBm.

### AC Test Circuits and Switching Time Waveforms

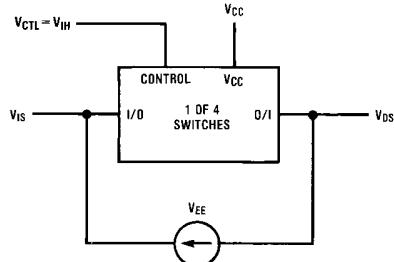


FIGURE 1. "ON" Resistance

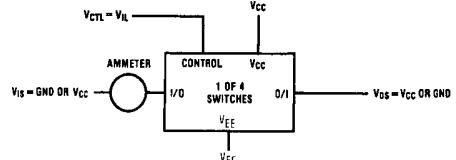


FIGURE 2. "OFF" Channel Leakage Current

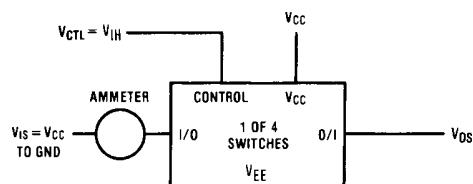
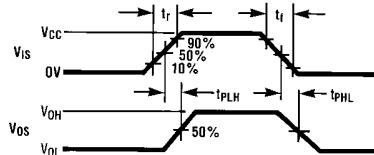
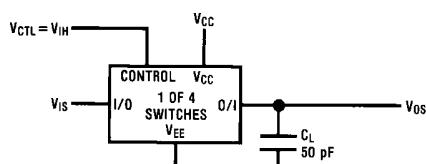
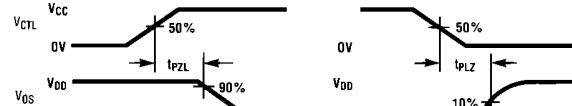
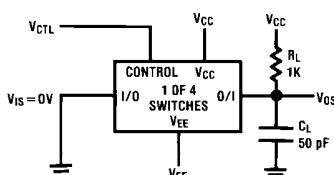
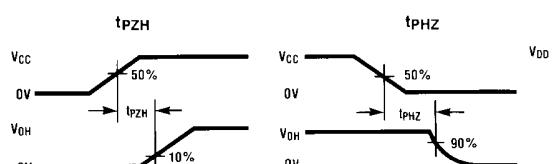
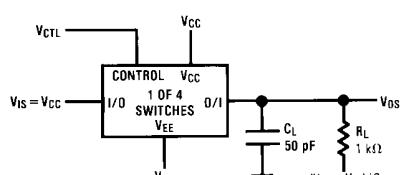


FIGURE 3. "ON" Channel Leakage Current

FIGURE 4.  $t_{PHL}$ ,  $t_{PLH}$  Propagation Delay Time Signal Input to Signal OutputFIGURE 5.  $t_{PZL}$ ,  $t_{PLZ}$  Propagation Delay Time Control to Signal OutputFIGURE 6.  $t_{PZH}$ ,  $t_{PHZ}$  Propagation Delay Time Control to Signal Output

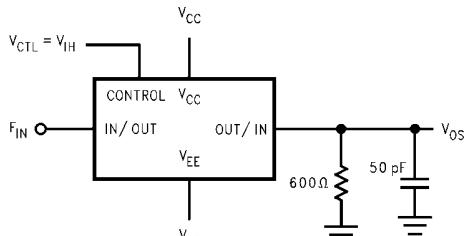
**AC Test Circuits and Switching Time Waveforms (Continued)**

FIGURE 7. Frequency Response

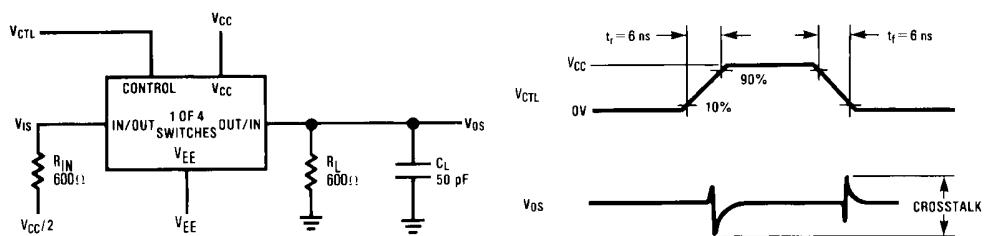


FIGURE 8. Crosstalk: Control Input to Signal Output

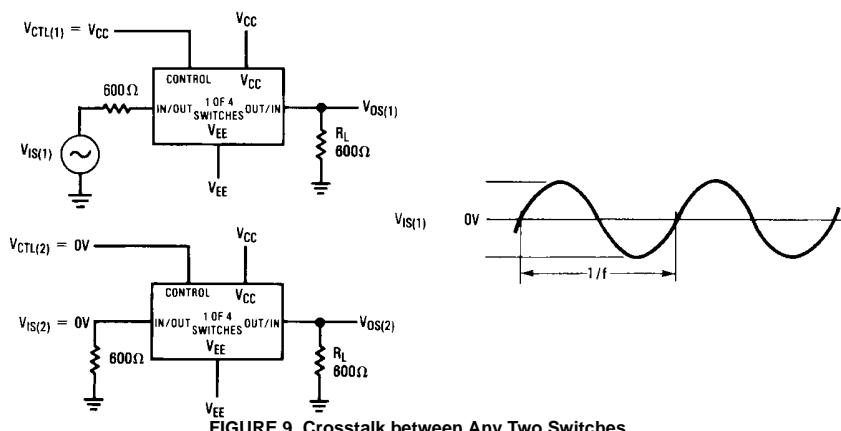


FIGURE 9. Crosstalk between Any Two Switches

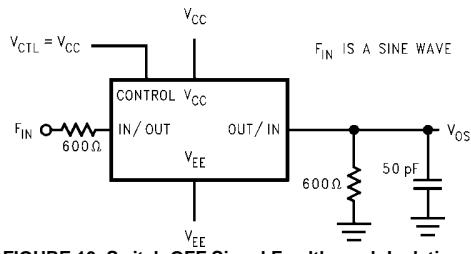


FIGURE 10. Switch OFF Signal Feedthrough Isolation

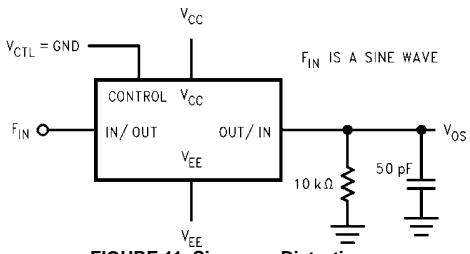
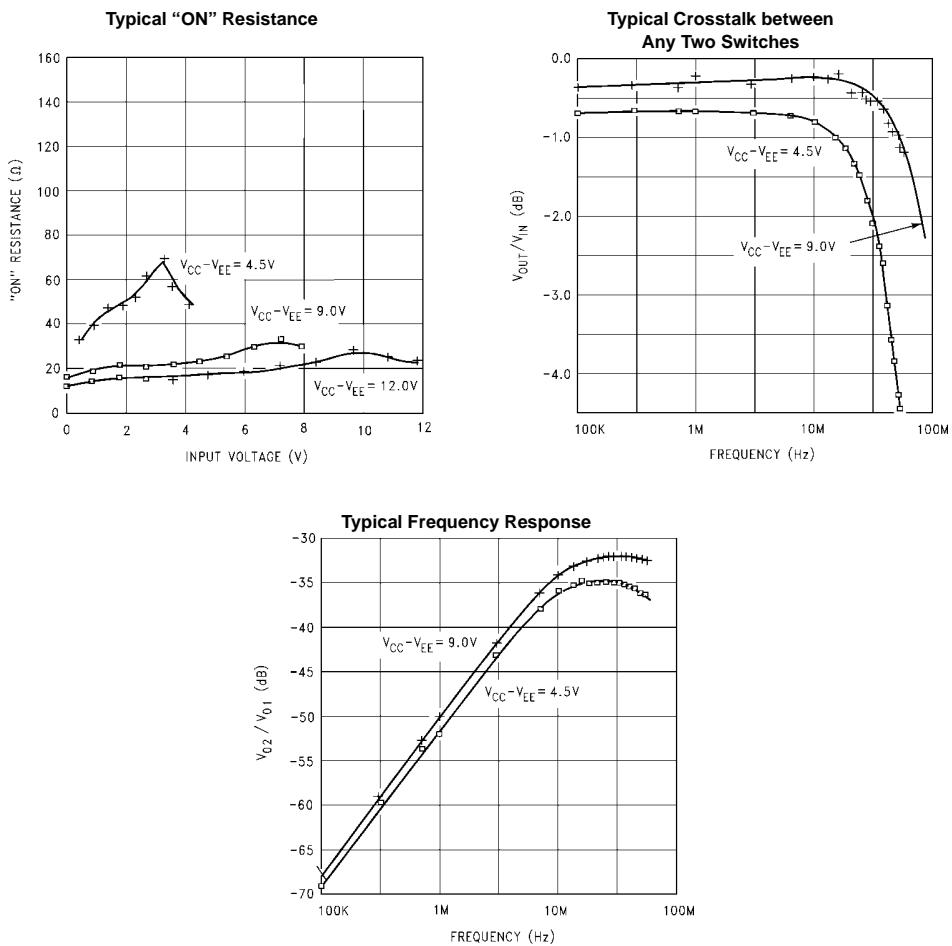


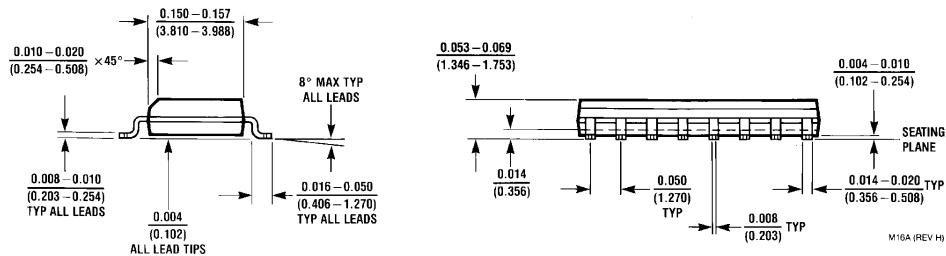
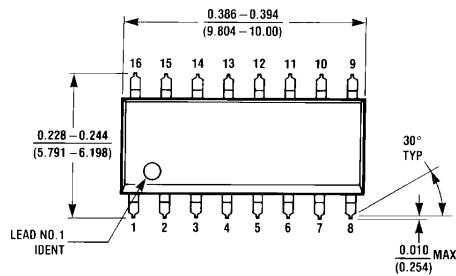
FIGURE 11. Sinewave Distortion

## Typical Performance Characteristics

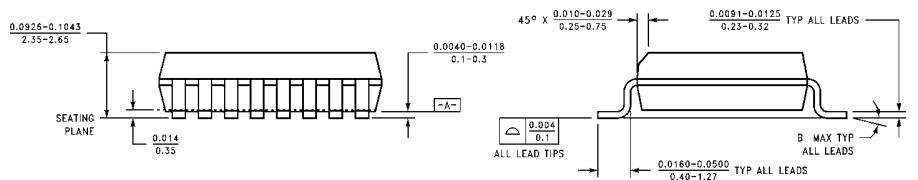
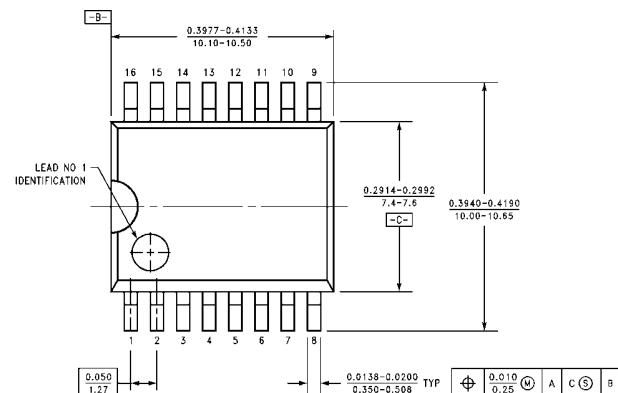


### Special Considerations

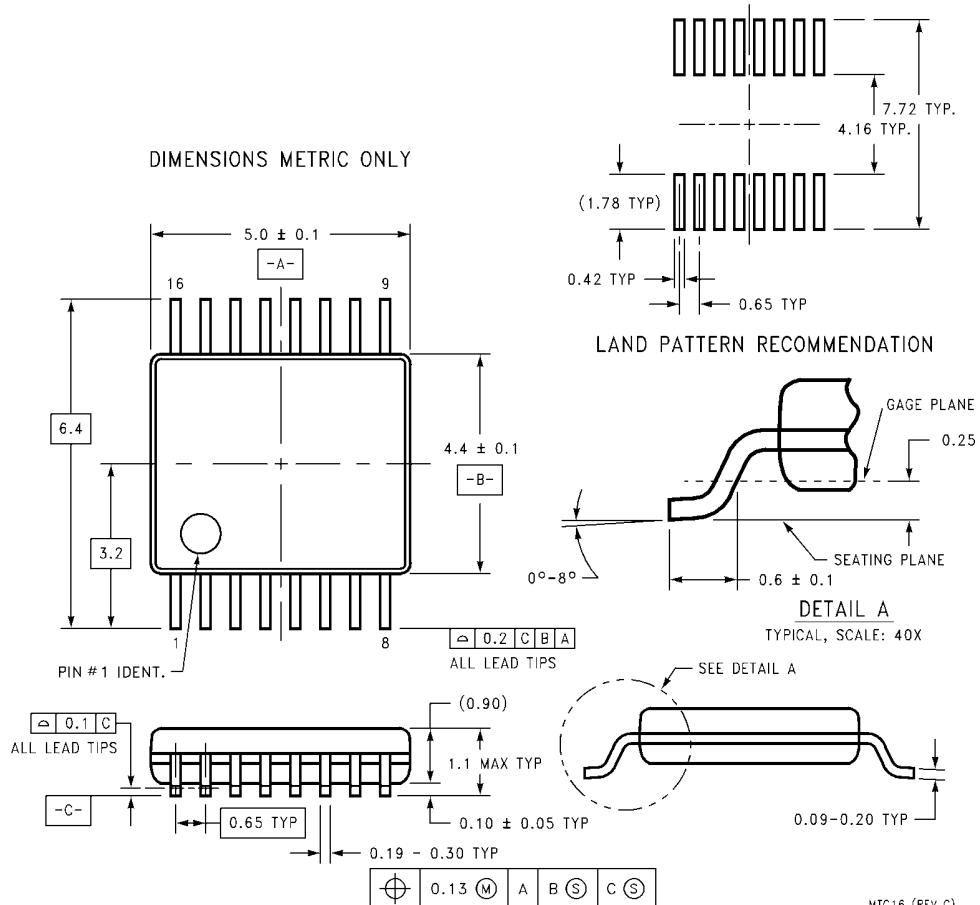
In certain applications the external load-resistor current may include both  $V_{CC}$  and signal line components. To avoid drawing  $V_{CC}$  current when switch current flows into the analog switch input pins, the voltage drop across the switch must not exceed 0.6V (calculated from the ON resistance).

**Physical Dimensions** inches (millimeters) unless otherwise noted


**16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow  
Package Number M16A**



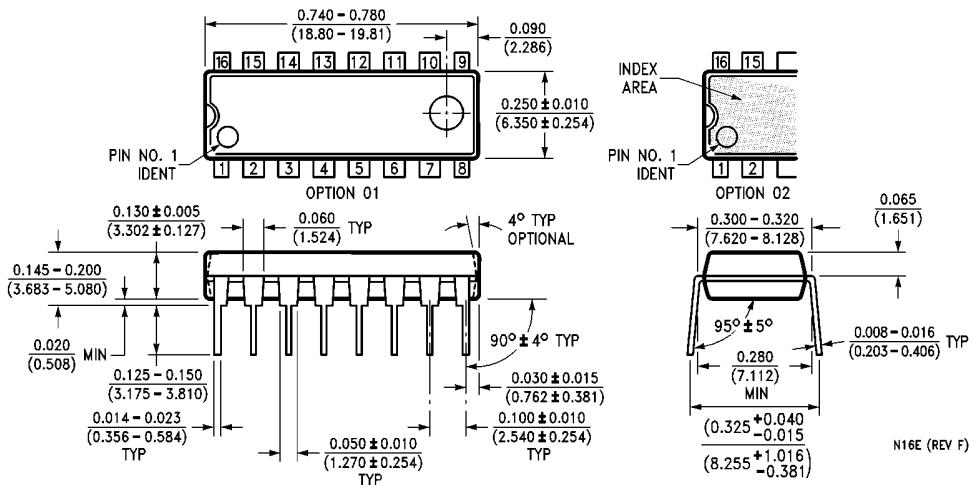
**16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide  
Package Number M16B**

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)

16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide  
Package Number MTC16

## 74VHC4316 Quad Analog Switch with Level Translator

### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide  
Package Number N16E**

### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

[www.fairchildsemi.com](http://www.fairchildsemi.com)